Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/790,583	WIEKHORST E	T AL.
Examiner	Art Unit	
Jinhee J. Lee	2831	

	SEAR	CHED	·
Class	Subclass	Date	Examiner
174	117as	3/30/2005	LEE
**	113as	3/30/2005	п
"	110r	3/30/2005	11
			i
-			

INT	ERFERENC	CE SEARCH	ED
Class	Subclass	Date	Examiner
174	as above	3/30/2005	Lee

SEARCH N (INCLUDING SEAR)	NOTES CH STRATEGY)
	DATE	EXMR
Chau Nguyen	3/29/2005	LEE
East text search attached	3/30/2005	LEE
		,